Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/661,579	NAKAGAWA ET AL.	
Examiner	Art Unit	
Diem Tran	3748	

SEARCHED		
Subclass	Date	Examiner
284. 285	10/24/05	DT
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	284. 285 297 299	Subclass Date 284. 10/24/05 285 297 299

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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